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Application/Control No.	Applicant(s)/Patent under Reexamination
10/811,817	CHAN ET AL.
Examiner	Art Unit
C. J. Arbes	3729

SEARCHED					
Class	Subclass	Date	Examiner		
29	830	2/21/2006	CJA		
1	852				
174	760				
	762				
361	780				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
852	2/21/2006	CJA			
	,				
	Subclass	Subclass Date			

(INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
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